# LATEST CHANGES IN BURST AND SURGE STANDARDS

José Antonio Fernández Sales Manager Western Europe and Middle East AMETEK CTS



# de Nederlandse EMC-ESD Vereniging EMC-ESD Event 2021



Hotel Van der Valk Vianen Dinsdag 23 november



# Burst: IEC 61000-4-4 Edition 3.0 (2012-04)

# Surge: IEC 61000-4-5 Edition 3.1 (2017-08)





### **BURST - HISTORY**

Date	Publication	Edition	Status
2012-04-30	IEC 61000-4-4:2012	3.0	Valid
2012-04-30	IEC 61000-4-4:2012 RLV	3.0	Valid
2011-03-30	IEC 61000-4-4:2004+AMD1:2010 CSV	2.1	Revised
2010-01-27	IEC 61000-4-4:2004/AMD1:2010	2.0	Revised
2007-06-06	IEC 61000-4-4:2004/COR2:2007	2.0	Revised
2006-08-15	IEC 61000-4-4:2004/COR1:2006	2.0	Revised
2004-07-08	IEC 61000-4-4:2004	2.0	Revised
2001-07-11	IEC 61000-4-4:1995/AMD2:2001	1.0	Revised
2000-11-09	IEC 61000-4-4:1995/AMD1:2000	1.0	Revised





# IMPORTANT CHANGES IN IEC 61000-4-4 1/2

#### / Version IEC 61000-4-4:2004 (Edition 2.0)

- The burst switch must be an electronic switch. It is not permitted to use a spark gap any longer
- Burst frequency 5 kHz at Td =15 ms or 100 kHz at Td = 0.75 ms
- Calibration at coaxial output of the simulator with 50  $\Omega$  and 1000  $\Omega$
- Calibration at output of the coupling network in Common Mode (all lines simultaneously) with 50  $\Omega$
- Coupling on supply lines in Common Mode (all lines simultaneously)
- Tabletop units are to be placed 0.1m above the ground reference plane
- For coupling on supply lines the length of the supply line was reduced to 0.5 m

#### / Version IEC 61000-4-4:2004+A1:2010 (Edition 2.0)

• The characteristics of the coupling-/ decoupling network were rectified and described precisely. Also the verification described in the Corrigendum 2 of 6/2007, which was internationally released, was not acceptable.





# **IMPORTANT CHANGES IN IEC 61000-4-4 2/2**

#### / Version IEC 61000-4-4:2012 (Edition 3.0)

- New version introduces calibration of capacitive coupling clamp. Procedure as well as impulse parameters are specified.
- Changes regarding calibration values at output of the coupling network:
  - Rise time (tr): 5,5ns ± 1,5ns
     Pulse duration (td): 45ns ± 15ns
- Distance between DUT and coupling device, both coupling network and/or coupling clamp are:
  - Devices mounted on table: 0,5m (-0/+0,1m)
  - Floor Standing devices: 1,0m (+/-0,1m)
- Test setup for rack mounted equipment.





# **TEST LEVEL SINCE IEC 61000-4-4:2004**

New repetition frequency of burst pulses is introduced!

Open circuit test voltage					
Level	Power line	I/O line			
	Peak volt	Repetition rate in kHz			
1	0,5	0,25	5 or <b>100</b>		
2	1	0,5	5 or <b>100</b>		
3	2	1	5 or <b>100</b>		
4	4	2	5 or <b>100</b>		
X (1)	special	special			

Table 1 – test level

The 100 kHz are merely a guideline, that could be adjusted by product committees to a more relevant variable for their product lines or products. In Annex A1 you will find representative values from real installations for your assistance.





# SIMPLIFIED CIRCUIT DIAGRAM



#### Components

Uhigh-voltage source $R_c$ charging resistor $C_c$ energy storage capacitor $R_s$ impulse duration shaping resistor $R_m$ impedance matching resistor $C_d$ d.c. blocking capacitorSwitchhigh-voltage switch

NOTE The characteristics of the switch together with stray elements (inductance and capacitance) of the layout shape the required rise time.

Figure 1 – Simplified circuit diagram showing major elements of a fast transient/burst generator





### **CHARACTERISTICS**

#### Single pulse

Rise time tr = 5 ns Pulse duration td = 50 ns



#### Pulse packet (Burst)

Repetition time Tr = 300 ms As formerly: Duration burst packet Td = 15 ms at spike frequency f = 5 kHz

<u>Newly added:</u> Duration burst packet Td = 0,75 ms At spike frequency f = 100 kHz



**∧ em**test / **T∃SEQ** / ③ MILMEGA /



### **CHARACTERISTICS - WAVEFORM -**

Output voltage range terminating with a load of 1000  $\Omega$ : min. 0.25 kV up to 4 kV; Output voltage range terminating with a load of 50  $\Omega$ : min. 0.125 kV up to 2 kV;

Pulse repetition frequency: Burst duration (see 6.1.2 and fig. 2):

#### **Pulse shape**

50  $\Omega$  Termination at coaxial output:

5 kHz and 100 kHz ± 20 % 15 ms ± 20 % at 5 kHz 0.75 ms ± 20 % at 100 kHz

Rise time tr = 5 ns  $\pm$  30 % Pulse duration (50 %-value) td = 50 ns  $\pm$  30 % Peak voltage = according table 2  $\pm$  10 %

1000  $\Omega$  Termination at coaxial out:

Rise time tr =  $5 \text{ ns} \pm 30 \%$ 

Pulse duration (50 %-value) td = 50 ns with a limiting deviation of – 15 ns bis + 100 ns Peak voltage = according table 2 ± 20 %



remtest / T35E0 / 🕲 MILMEGA / 🌆

## CHARACTERISTICS - OUTPUT VOLTAGE PEAK -

Set voltage	Set voltage V <sub>p</sub> (open circuit)		V <sub>p</sub> (50 Ω)	Repetition frequency	
kV	k∨	k∨	k∨	kHz	
0,25	0,25	0,24	0,125	5 or 100	
0,5	0,5	0,48	0,25	5 or 100	
1	1	0,95	0,5	5 or 100	
2	2	1,9	1	5 or 100	
4	4	3,8	2	5 or 100	
Measures should be	e taken to ensure that st	ray capacitance is kept	to a minimum.		
NOTE 1 Use of a	1 000 $\Omega$ load resistor w	ill automatically result	in a voltage reading t	hat is 5 % lower than	
the set voltage, as	shown in column $V_{\rm p}$ (1	000 $\Omega$ ). The reading $V$	$V_{\rm p}$ at 1 000 $\Omega$ = $V_{\rm p}$ (o)	pen circuit) multiplied	
times 1 000/1 050 (the ratio of the test load to the total circuit impedance of 1 000 $\Omega$ plus 50 $\Omega$ ).					
NOTE 2 With the 50 $\Omega$ load, the measured output voltage is 0,5 times the value of the unloaded voltage as					
reflected in the table above.					

Table 2 – Output voltage peak values and repetition frequencies





# CALIBRATION AT THE COAXIAL OUTPUT, 50 OHM





**Ratio with KW50 ->** 400:1 Example: 2000V Burst = 5V on scope



**~ em**test / T∃SEO / ③ MILMEGA / ④

# CALIBRATION AT THE COAXIAL OUTPUT, 1000 OHM





**Ratio with KW1000 ->** 1000:1 Example: 2000V Burst = 2V on scope



**∧ em**test / **T∃SEQ** / ③ MILMEGA / ④

# CALIBRATION AT COUPLING/DECOUPLING NETWORK 1/3

#### **Coupling/decoupling network for mains supply connectors**

Proof of characteristics of coupling/decoupling network:

The pulse shape has to be proved at each output/path of coupling-/decoupling network

- Therefore all coupling paths are set simultaneously (Common Mode)
- The output of the coupling network is terminated with a coaxial load of 50  $\Omega$

The calibration has to be provided with a voltage setting of 4kV as follows:

	since EN 61000-4-4:2004	New: EN 61000-4-4:2012
Rise time <b>tr</b>	5 ns ± 30%	5,5ns ± 1,5ns
Pulse duration td	50 ns ± 30%	45ns ± 15ns
peak value of voltage	$\pm$ 10% of the voltage according t	o table

✓ emtest / T∃SEQ / ③ MILMEGA

#### Remark:

The procedure is as shown in the above norm, until publication of the Amendment A1 to IEC 61000-4-4 ed.2 from 01-2010 hotly contested. In its current version, the verification is made abundantly clear.



# CALIBRATION AT COUPLING/DECOUPLING NETWORK 2/3

#### Procedure since Amendment A1 to IEC61000-4-4 ed.2 of 01/2010

The calibration is performed with the generator output at 4 kV. The generator is connected to the input of the coupling/decoupling network. Each individual output of the CDN (normally connected to the EUT) is terminated in a sequence with a 50 Ω load while the other outputs are open. The peak voltage and waveform are recorded for each polarity.



Figure 5 - Calibration of the waveform at the output of the coupling/decoupling network

✓ emtest / T∃SEQ / ③ MILMEGA



# CALIBRATION AT COUPLING/DECOUPLING NETWORK 3/3

- The EFT transients are coupled to all lines of the CDN simultaneously (CM).
- The output of the CDN <u>shall</u> <u>not be short circuited</u>.
- <u>The EFT transients shall be</u> <u>measured at each individual</u> <u>output of the CDN</u> <u>with 50Ω load, while the</u> <u>other outputs are open.</u>
- Each individual output must show the transients within the tolerances as specified.



1.





# CALIBRATION OF CAPACITIVE COUPLING CLAMP 1/2

- The transducer plate consists of a metallic sheet of 120 mm x 1050 mm of max 0.5 mm thickness, isolated on top and bottom by a dielectric foil of 0.5 mm. Isolation for 2.5 kV on all sides must be guaranteed in order to avoid the clamp to contact the transducer plate.
- The transducer plate is to be inserted into the coupling clamp and must be terminated at the opposite end of the generator connection with a coaxial load of 50  $\Omega$ .
- The calibration is performed with the generator output voltage set to 2 kV. The calibration have to meet the following requirements:

Rise time <b>tr</b>	5 ns ± 1,5 ns
Pulse duration <b>td</b>	50 ns $\pm$ 15 ns
peak value of voltage	$1 \text{ kV} \pm 200 \text{ V}$



Figure 8 – Calibration of capacitive coupling clamp using the transducer plate





## **CALIBRATION OF CAPACITIVE COUPLING CLAMP 2/2**



#### **Calibration setup**

of a capacitive coupling clamp using the transducer plate acc. to figure 8 of IEC 61000-4-4:2012







# **COMMON MODE COUPLING**

#### Coupling mode: "all lines against ground reference "

So, the coupling mode is a pure "Common Mode testing". This means that the testing of single lines, line after line, is not demanded any more, but only all lines simultaneously must be supplied with burst pulses.







# CABLE LENGTH EUT-CDN: ACC. IEC 61000-4-4:2012

#### Test set-up for type tests in laboratory on main supply lines

- The new standard defines the distance and not the cable length.
- There is a distinction between floor standing equipment and table top equipment.





**~ em**test / T∃SEO / ③ MILMEGA / ④



# Burst: IEC 61000-4-4 Edition 3.0 (2012-04)

# Surge: IEC 61000-4-5 Edition 3.1 (2017-08)





### **SURGE - HISTORY**

Date	Publication	Edition	Status
2017-08-04	IEC 61000-4-5:2014/AMD1:2017	3.0	Valid
2017-08-04	IEC 61000-4-5:2014+AMD1:2017 CSV	3.1	Valid
2009-10-20	IEC 61000-4-5:2005/COR1:2009	2.0	Revised
2005-11-29	IEC 61000-4-5:2005	2.0	Revised
2001-04-26	IEC 61000-4-5:1995+AMD1:2000 CSV	1.1	Revised
2000-11-09	IEC 61000-4-5:1995/AMD1:2000	1.0	Revised
1995-03-01	IEC 61000-4-5:1995/COR1:1995	1.0	Revised
1995-02-01	IEC 61000-4-5:1995	1.0	Revised





# **IMPORTANT CHANGES IN IEC 61000-4-5 ED. 3**

- Pulse parameters changed, now it is only one-time definition of pulse shapes (front time T<sub>f</sub> and pulse duration T<sub>d</sub>)
- Verification of the Waveforms have to be made at the generator output (with 18μF in serial), and at the output of the coupling/decoupling networks.
- Harmonization of CDN up to 200 A
- New verification procedure for data line CDN's, new calibration table. For verification the open-circuit voltage and the short-circuit current will measured. Additionally the AE-port should be open and not connected.
- The impedance for tests on shielded lines are 2 Ohm + 18  $\mu$ F.
- New test setup for shielded control lines which are grounded only at one end. In this case the lines will be tested like unshielded lines.
- No line-to-ground surges are applied for double-insulated products (i.e. products without any dedicated earth terminal). This applies to the power supply lines as well as for signal and data lines.
- The coupling network for symmetrical operated telecommunication lines which will be used for tests with the T-Surge waveform (10/700 µs) is changed. The effective impedance of the coupling path has been changed.
- Measurement Uncertainty MU in annex D.







#### Table 1 – Test levels

l evel	Open-circuit test voltage ±10 %		
2000	kV		
1	0,5		
2	1,0		
3	2,0		
4	4,0		
Х	Special		
NOTE X can be any level, above, below or in between the other levels. This level can be specified in the product standard.			

#### IEC 61000-4-5:2005 (Ed. 2)

#### Table 1 – Test levels

	Open-circ	cuit test voltage
Level		kV
	Line-to-line	Line-to-ground <sup>b</sup>
1	( <del></del> )	0,5
2	0,5	1
3	1	2
4	2	4
Xa	Special	Special
"X" can be an specified in the For symmetric simultaneously	y level, above, below or in be e dedicated equipment specifica al interconnection lines the t with respect to ground, i.e. "line	etween the others. The level shall be tion. est can be applied to multiple lines es to ground".

#### IEC 61000-4-5:2017 (Ed. 3)





# **SURGE PULSE DEFINITION IEC 61000-4-5:2005 ED. 2** 1/2

Definitions	In accordance	e with IEC 60060-1	In accordance with IEC 60469-1		
	Front time µs	Time to half value μs	Rise time (10 % – 90 %) µs	Duration time (50 % – 50 %) μs	
Open-circuit voltage	1,2 ± 30 %	50 ± 20 %	1 ± 30 %	50 ± 20 %	
Short-circuit current	8 ± 20 %	20 ± 20 %	6,4 ± 20 %	16 ± 20 %	
NOTE In existing IEC p shown in Figures 2 and 2 in Table 2.	publications, the wavefor 3. Other IEC recommen	orms 1,2/50 μs and 8/20 μs are indations are based on wavefor	e generally defined accord m definitions according to	l ding to IEC 60060-1 as o IEC 60469-1 as shown	
Both definitions are valid	for this part of IEC 610	000 and describe just one sing	le generator.		

#### Table 2 – Definitions of the waveform parameters 1,2/50 $\mu s$ – 8/20 $\mu s$





# **SURGE PULSE DEFINITION IEC 61000-4-5:2005 ED. 2** 2/2

#### Definition according IEC 60060-1:

 Front time:
  $T_1 = 1.67xT = 1.2 \ \mu s \pm 30 \ \%$  

 Time to half value:
  $T_2 = 50 \ \mu s \pm 20 \ \%$ 



#### Definition according IEC 60469-1:

Rise time (10% - 90%):tr=1  $\mu$ s ± 30 %Duration time (50% - 50%):td=50  $\mu$ s ± 30 %



**~ em**test / T∃SEQ / ③ MILMEGA / ④

# SURGE PULSE DEFINITION IEC 61000-4-5:2017 ED. 3

• Open circuit voltage : 1.2/50 μs

Front Time: $T_f = 1.67 \text{ x T} = 1.2 \text{ } \mu \text{s} \text{ } \pm 30 \text{ } \%$ Duration: $T_d = \text{Tw} = 50 \text{ } \mu \text{s} \text{ } \pm 20 \text{ } \%$ 

NOTE: The open circuit voltage waveform at the output of the coupling/decoupling network may have a considerable undershoot, in principle as the curve shown in Figure



V 100% 90% 50% 10% 0% Tr 30% mak

• Short circuit current: 8/20 μs

Front Time :  $T_f = 1.25 \text{xTr} = 8 \ \mu \text{s} \pm 20 \ \%$ Duration:  $T_d = 1.18 \ \text{xTw} = 20 \ \mu \text{s} \pm 20 \ \%$ 

NOTE : The 30 % undershoot specification applies only at the generator output. At the output of the coupling/decoupling network there is no limitation on undershoot or overshoot.



**~ em**test / T∃SEQ / ③ MILMEGA / ④

# CALIBRATION COUPLING NETWORK IEC 61000-4-5:2017 ED. 3 1/2

#### 6.4.2 Calibration of CDNs for a.c./d.c. mains supply rated up to 200A per line

The characteristics of the CDN shall be measured under *open-circuit* conditions (load greater than or equal to 10 kOhm) and under *short-circuit* conditions at the same set voltage.

All performance characteristics stated in 6.3.2 Tables 4 and 5 shall be met at the CDN output.

Table 4 – Voltage w	aveform at EUT port of CDN

Surge voltage parameters under open-circuit conditions <sup>a</sup>	Coupling impedance		
	18 µF	9 μF + 10 Ω	
Peak voltage			
Current rating ≤ 16 A	Set voltage +10 %/-10 %	Set voltage +10 %/-10 %	
16 A < Current rating ≤ 32 A	Set voltage +10 %/-10 %	Set voltage +10 %/-10 %	
32 A < Current rating ≤ 63 A	Set voltage +10 %/-10 %	Set voltage +10 %/-15 %	
63 A < Current rating ≤ 125 A	Set voltage +10 %/-10 %	Set voltage +10 %/- 20 %	
125 A < Current rating ≤ 200 A	Set voltage +10 %/-10 %	Set voltage +10 %/- 25 %	
Front time	1,2 µs ± 30 % 1,2 µs ± 30 %		
Duration			
Current rating ≤ 16 A	50 µs +10 µs/-10 µs	50 µs +10 µs/-25 µs	
16 A < Current rating ≤ 32 A	50 µs +10 µs/-15 µs	50 µs +10 µs/-30 µs	
32 A < Current rating ≤ 63 A	50 µs +10 µs/-20 µs	50 µs +10 µs/-35 µs	
63 A < Current rating ≤ 125 A	50 µs +10 µs/-25 µs	50 µs +10 µs/-40 µs	
125 A < Current rating ≤ 200 A	50 µs +10 µs/-30 µs	50 µs +10 µs/-45 µs	
<sup>8</sup> The measurement of the surge voltage parameters shall be done with the a c/d c, mains			

<sup>a</sup> The measurement of the surge voltage parameters shall be done with the a.c./d.c. mains supply port of the CDN open-circuit.

#### New in Ed. 3

- Waveshape defined for common mode coupling to PE
- Tolerances are increased at higher current in the coupling network.

Decoupling inductivity: - Maximum 1.5 mH - Voltage Drop CDN < 10%



remtest / TISEO / 🕲 MILMEGA / 🌆

# CALIBRATION COUPLING NETWORK IEC 61000-4-5:2017 ED. 3 2/2

It is the intention of this standard that the output waveforms meet specifications at the point where they are to be applied to the EUT. The characteristics of the generator shall be measured under:





Open circuit voltage with HV-Probe

each: DM: L-N CM: L-PE CM: N-PE

Short circuit current with current probe

each: DM: L-N CM: L-PE CM: N-PE









## **CALIBRATION OF CDNS FOR UNSYMMETRICAL INTERCONNECTION LINES**

New in Ed. 3: Waveform specification for unsymmetrical interconnection lines – was NOT specified in Ed. 2

Coupling method	CWG Output voltage <sup>1,2,3</sup> )	Voc at CDN EUT output ± 10 %	Voltage Front time $T_f$ $T_f = 1,67 \times T_r$ $\pm 30 \%$	Voltage Duration T <sub>d</sub> T <sub>d</sub> = T <sub>w</sub> ± 30 %	/sc at CDN EUT output ±20 %	Current Front Time $T_f$ $T_f = 1,25 \times T_r$ $\pm 30 \%$	Current Duration <i>T<sub>d</sub></i> <i>T<sub>d</sub></i> =1,18x <i>T</i> <sub>w</sub> ± 30 %
Line to PE R = 40 Ω CD = 0,5 μF	4 k∨	4 kV	1,2 µs	38 µs	87 A	1,3 µs	13 µs
Line to PE R = 40 Ω CD = GDT	4 k∨	4 k∨	1,2 µs	42 µs	95 A	1.5 µs	48 µs
Line to Line R = 40 Ω CD = 0,5 μF	4 k∨	4 k∨	1,2 µs	42 µs	87 A	1,3 µs	13 µs
Line to Line R = 40 Ω CD = GDT	4 k∨	4 kV	1,2 µs	47 µs	95 A	1,5 µs	48 µs

Table 8 – Surge waveform specs. at the EUT port of the CDN

<sup>1</sup>) It is recommended to calibrate the CDN at the highest rated pulse voltage, as this will minimise the effects of the switching noise generated by CLDs and GDTs. The value shown in the table is for a generator setting of 4kV. In case the CDN is rated for another maximum pulse voltage, the calibration shall be done at this maximum rated pulse voltage. The short circuit peak current specification shall be adapted accordingly. e.g. If the Maximum voltage is 1kV the short circuit current value shown in this table shall be multiplied by 1/4

<sup>2</sup>) Coupling via gas arrestors, clamping or avalanche devices will show some switching noise on the pulse waveform. Working with the highest possible pulse voltage will minimise their impact on measurements; it is recommended to neglect the switching noise for the front times and duration values measurements.

<sup>3</sup>) The values shown in this table are for a CWG with ideal values. In case the CWG generates parameter values close to the tolerances, the additional tolerances of the CDN may generate values out of tolerances for the CWG-CDN combination.





# CALIBRATION PROCESS FOR SYMMETRICAL INTERCONNECTION LINES

New in Ed. 3: Measurements shall be performed with the impulse applied to one coupling path at a time.

The peak amplitude, the front time and impulse duration shall be measured for the CDN rated impulse voltage under opencircuit conditions.

The inputs of the CDN at the auxiliary equipment (AE) side shall be short circuited to PE for the impulse voltage and impulse current measurement at the EUT output port.

		Cou	pling	Measuring		AE side	EUT side	
Surge voltage at EUT side		Common mode – all lines to PE		All lines shorted together	All lin PE	lines shorted to	Open circuit – all lines connect together	Table 9: Calibration process
		*) 40 Ω path		Peak voltage, from time, duration	nt			
Surge current at EUT side		Common mode – all lines to PE		All lines shorted together	All lin PE	es shorted to	All lines shorted to PE	
		*) 40 Ω path		Peak current, fror time, duration	nt			
Residual voltage on AE side		Common mode – all lines to PE		Line to PE at a tir Peak voltage	ne Open	circuit	Open circuit	
		*) 40 Ω pat	h	Cak Voltage				
*) 40 Ω path or 40 Ω per p 320 Ω per lin	means that t pair are used ne or 160 Ω p	he transfer im , for coupling t er pair are use	pedance is alw to 2 pairs 160 s ed.	ays 40 Ω, this me Ω per line or 80 Ω	eans that for c 2 per pair are	oupling to 1 pa used, for coupli	ir 80 $\Omega$ per line ing to 4 pairs	
Coupling method	CWG Output voltage	Voc at CDN EUT output	Voltage Front time 7	Voltage Tr Duration Td	<i>l</i> scatCDN EUToutput	Current Front Time	Current T <sub>r</sub> Duration T <sub>d</sub>	
		± 10 %	± 30 %	± 30 %	± 20 %	± 30 %	± 30 %	
	<sup>1</sup> ), <sup>2</sup> ), <sup>3</sup> )							Table 10: Waveform specification
Common mode CD, 40 Ω path	2 kV	2 kV	1,2 µs	42 µs	48 A	1,5 µs	45 µs	



**~ em**test / T∃SEQ / ③ MILMEGA / ④

# **FLOW CHART FOR COUPLING METHOD**





**~ em**test / **T∃SEQ** / ③ MILMEGA / ④

### **TEST SET-UP FOR SHIELDED LINES GROUNDED AT BOTH SIDES**

For EUTs which do not have metallic enclosures, the surge is applied directly to the shielded cable at the EUT side.





**∧ em**test / **T∃SEO** / ③ MILMEGA / ④

# **TEST SET-UP FOR SHIELDED LINES GROUNDED ONLY AT ONE END**

600

According to IEC 61000-4-5:2004: The test is done with an open end at the AE side.



#### According to IEC61000-4-5 Ed. 3:

The test is done as for unshielded asymmetrically

operated I/O lines

601	a) Shields grounded at both ends

602 - the test shall be carried out according to Figure 12.

Rules for application of the surge to shielded lines:

603 The test level is applied on shields with a 2  $\Omega$  generator source impedance.

604 b) Shields grounded at one end

- 605 the test shall be carried out according to 7.4 or 7.5 (see Figure 4) because the shield does not provide any protection against surges induced by magnetic fields.
- 607 NOTE In this case, surge testing is not applied to the shield.

608 For EUTs which do not have metallic enclosures, the surge is applied directly to the shielded cable at the 609 EUT side.





# **COUPLING ON HIGH-SPEED I/O LINES**

Figure 11 shows an example of a coupling and decoupling network for symmetrical interconnection lines allowing tests with interconnection speed up to 1 000 Mbit/s.



symmetrical interconnection lines





**∼em**test / **T∃SEO** / ③ MILMEGA /





# THANK YOU!

# You can contact us via Accelonix B.V.

de Nederlandse EMC-ESD Vereniging EMC-ESD Event 2021

Hotel Van der Valk Vianen Dinsdag 23 november